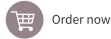


## **BAT24-02LS**

### Single silicon RF Schottky diode









## **Product description**

This Infineon RF Schottky diode is a silicon low barrier N-type device with an integrated guard ring on-chip for over-voltage protection. Its low barrier height, small forward voltage and low junction capacitance make BAT24-02LS a suitable choice for mixer and detector functions in applications which frequencies are as high as 24 GHz.



#### Feature list

- Low inductance L<sub>S</sub> = 0.2 nH (typical)
- Low capacitance C = 0.2 pF (typical) at voltage  $V_R = 0$  V and frequency f = 1 MHz
- TSSLP-2-1 package (0.62 mm x 0.32 mm x 0.31 mm) with a 0201 foot print
- Pb-free, RoHS compliant and halogen free

#### **Product validation**

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22.

## **Potential applications**

For mixers and detectors in:

• Radar systems and modules

### **Device information**

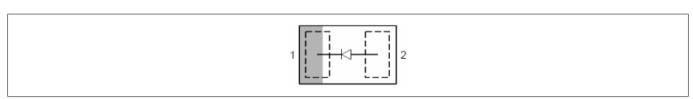


Table 1	Part information				
Product nam	e / Ordering code	Package	Pin configuration	Marking	Pieces / Reel
BAT24-02LS /	BAT2402LSE6327XTSA1	TSSLP-2-1	Single, leadless	S	15 k

Attention: ESD (Electrostatic discharge) sensitive device, observe handling precautions!

#### Single silicon RF Schottky diode



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#### **Table of contents**

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## 1 Absolute maximum ratings

Table 2 Absolute maximum ratings at T<sub>A</sub>= 25°C, unless otherwise specified

Parameter	Symbol	Values		Unit	Note or test condition	
		Min. Max.				
Diode reverse voltage	$V_{R}$	_	4	V		
Forward current	I <sub>F</sub>	_	110	mA		
Total power dissipation	$P_{TOT}$	_	100	mW	T <sub>S</sub> ≤ 82°C <sup>1)</sup>	
Junction temperature	TJ	_	150	°C		
Operating temperature	$T_{OP}$	_	150			
Storage temperature	$T_{STG}$	_	150			

Attention: Stresses above the maximum values listed here may cause permanent damage to the device.

Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Exceeding only one of these values may cause irreversible damage to the component.

 $T_{\rm S}$  is the soldering point temperature.

#### **Electrical performance in test fixture**



## 2 Electrical performance in test fixture

#### 2.1 Electrical characteristics

Table 3 Electrical characteristics at  $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Breakdown voltage	$V_{BR}$	4	-	_	V	$I_{R} = 10 \mu A$
Reverse current	I <sub>R</sub>	_	_	5	μΑ	V <sub>R</sub> = 1 V
Forward voltage	$V_{R}$	0.16	0.25	0.32	V	/ <sub>F</sub> = 1 mA
		0.25	0.35	0.41		/ <sub>F</sub> = 10 mA
Differential forward resistance	$R_{F}$	_	8	10	Ω	$I_{\rm F} = 10  \text{mA}  /  50  \text{mA}^{2}$
Capacitance	С	_	0.2	0.23	pF	$V_{R} = 0 \text{ V}, f = 1 \text{ MHz}$
Inductance	L <sub>S</sub>	0.15	0.2	0.25	nH	3)

#### 2.2 Characteristic curves

At  $T_A$  = 25 °C, unless otherwise specified

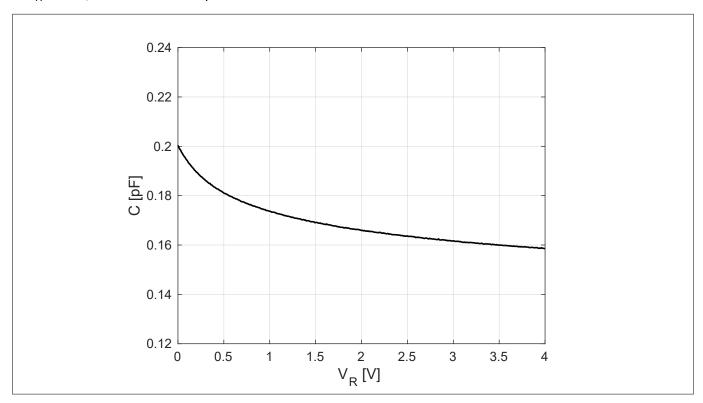


Figure 1 Capacitance C vs. reverse voltage  $V_R$  at frequency f = 1 MHz

 $R_F = \frac{V_F(50 \text{ mA}) - V_F(10 \text{ mA})}{50 \text{ mA} - 10 \text{ mA}}$ 

Parameter is not subject to production test, min/max values are specified by design.



### **Electrical performance in test fixture**

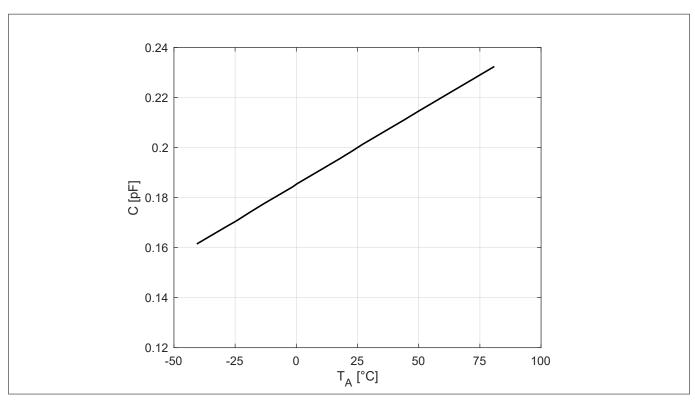


Figure 2 Capacitance C vs. ambient temperature  $T_A$  at frequency f = 1 MHz and reverse voltage  $V_R = 0$  V

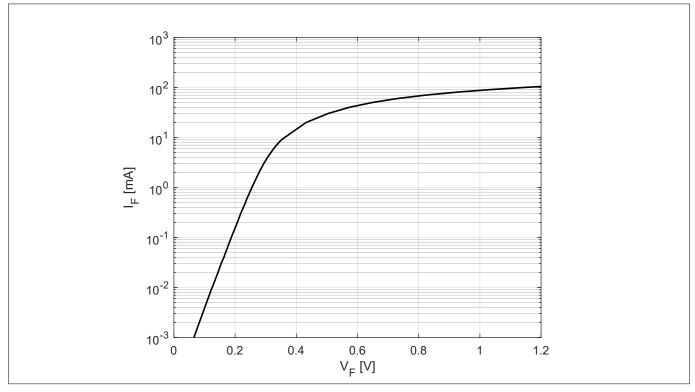


Figure 3 Forward current  $I_F$  vs. forward voltage  $V_F$ 

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### **Electrical performance in test fixture**

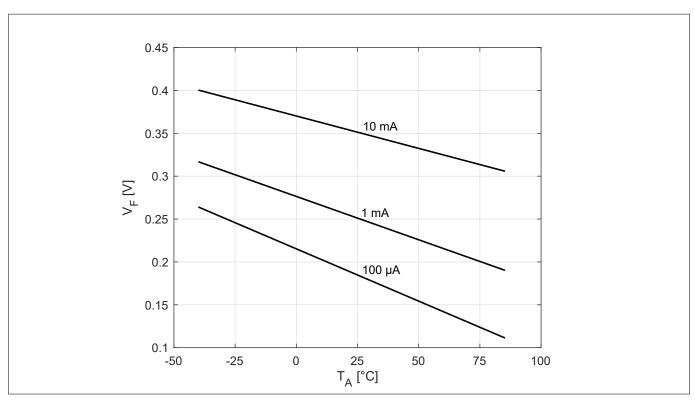


Figure 4 Forward voltage  $V_F$  vs. ambient temperature  $T_A$  at different forward currents

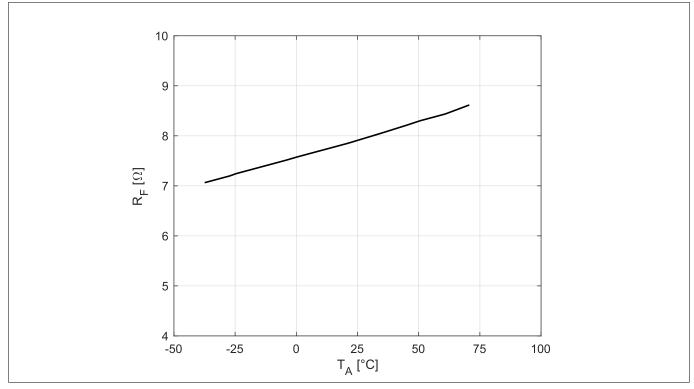


Figure 5 Differential forward resistance  $R_F$  vs. ambient temperature  $T_A$  between forward currents  $I_F = 10$  mA and 50 mA

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#### **Electrical performance in test fixture**

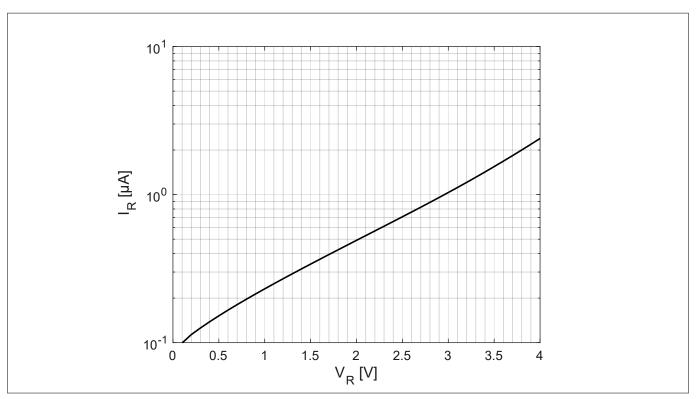


Figure 6 Reverse current  $I_R$  vs. reverse voltage  $V_R$ 

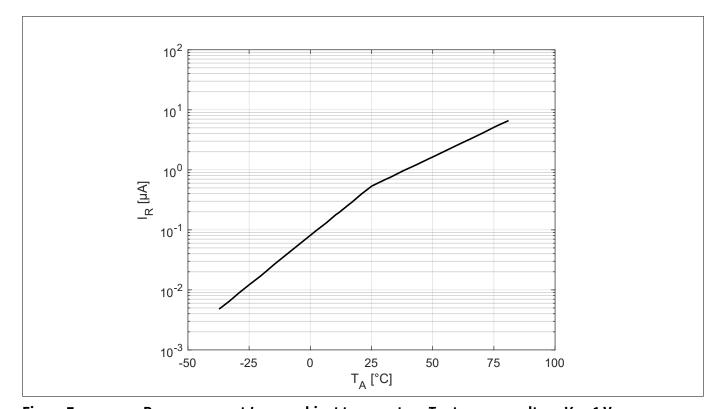


Figure 7 Reverse current  $I_R$  vs. ambient temperature  $T_A$  at reverse voltage  $V_R = 1 \text{ V}$ 

**Note**: The curves shown in this chapter have been generated using typical devices but shall not be understood as a guarantee that all devices have identical characteristic curves.

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**Thermal characteristics** 

## **3** Thermal characteristics

Table 4 Thermal resistance

Parameter	Sym	Values			Unit	Note or test condition
	bol	Min.	Тур.	Max.		
Thermal resistance	$R_{thJS}$	-	675	_	K/W	$T_{\rm S} = 82 {}^{\circ}{\rm C}^{4)}$
(junction - soldering point)						

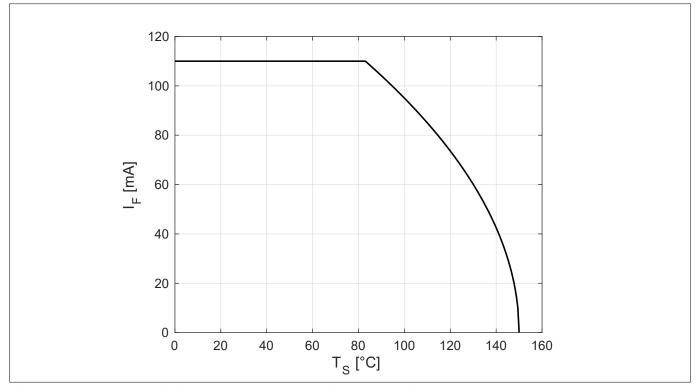


Figure 8 Permissible forward current I<sub>F</sub> in DC operation

For  $R_{thJS}$  in other conditions refer to the curves in this chapter.

## Single silicon RF Schottky diode

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#### **Thermal characteristics**

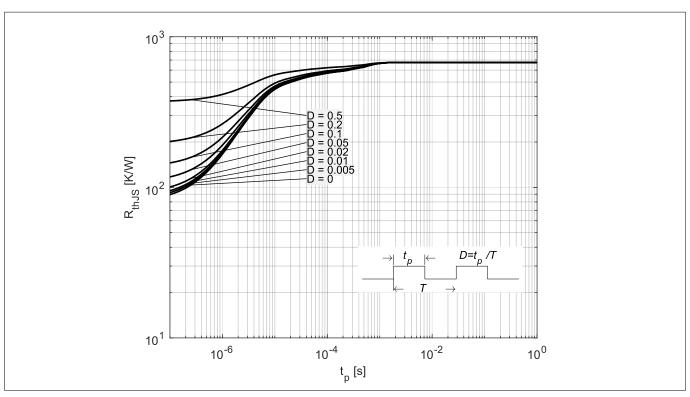


Figure 9 Thermal resistance R<sub>thJS</sub> in pulse operation

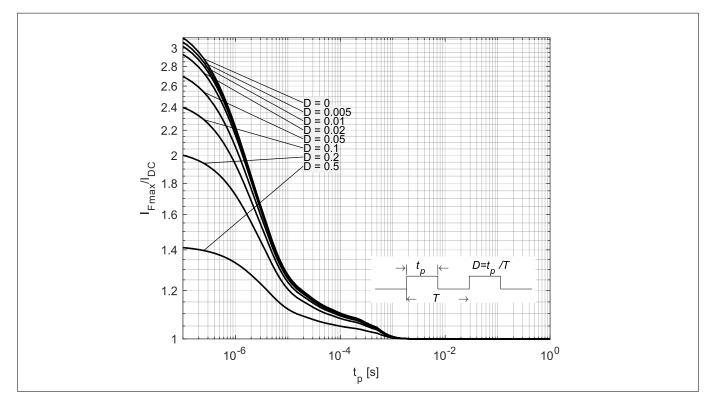


Figure 10 Permissible forward current ratio  $I_{Fmax}/I_{DC}$  in pulse operation



## 4 Package information TSSLP-2-1

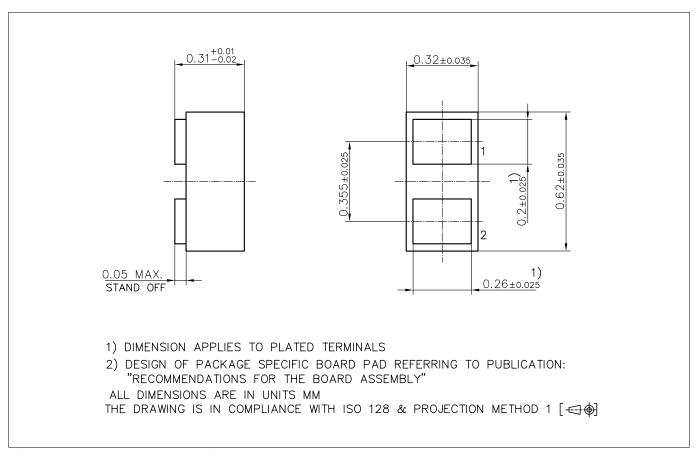


Figure 11 Package outline

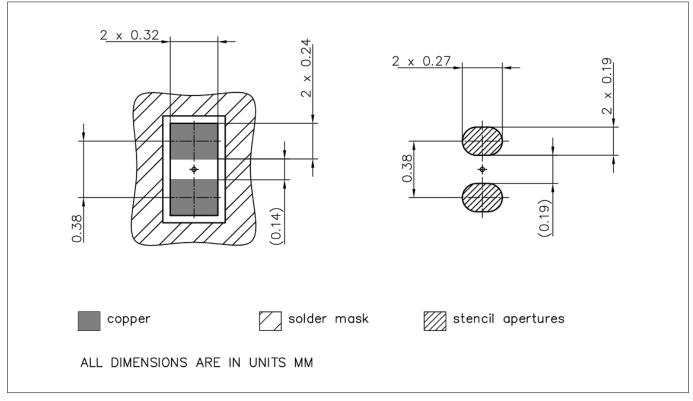


Figure 12 Foot print

#### Single silicon RF Schottky diode



#### Package information TSSLP-2-1

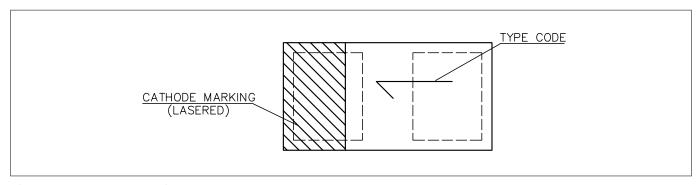


Figure 13 Marking layout example

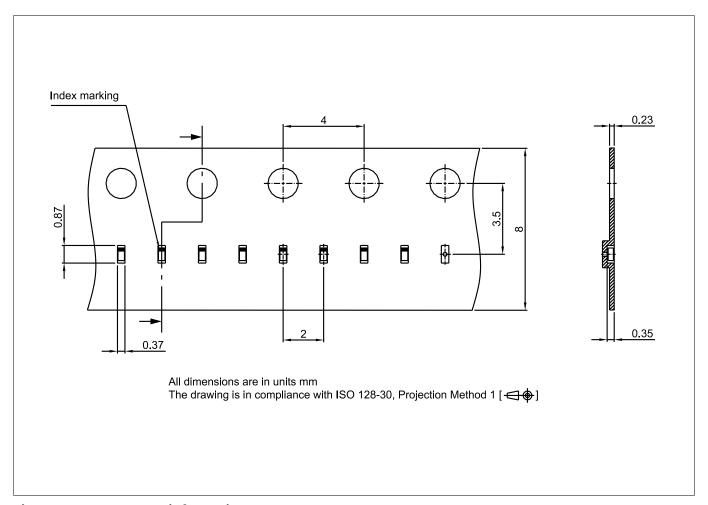


Figure 14 Tape information

**Note**: For recommendation on board assembly see the website of package PG-TSSLP-2-1.

The marking layout is an example. For the real marking code refer to the device information on the first page. The number of characters shown in the layout example is not necessarily the real one. The marking layout can consist of less characters.

#### **BAT24-02LS**

## Single silicon RF Schottky diode



#### References

## 5 References

[1]	Infineon AG - Product webpage for BAT24-02LS
[2]	Infineon AG - Package webpage for PG-TSSLP-2-1

# **Revision history**

Document version	Date of release	Description of changes
2.0	2018-09-07	<ul> <li>New layout of datasheet</li> <li>Typical values and curves updated to the values of the production (No product or process change behind)</li> </ul>
2.2	2023-12-04	Tape change: New tape drawing

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